

**Search Notes**

Application/Control No.

10/602,194

Examiner

Khiem D. Nguyen

Applicant(s)/Patent under  
Reexamination

ONO, YOSHI

Art Unit

2823

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
IEEE	3/9/2005	K.N.